


<b>Search Notes</b>  	<b>Application/Control No.</b>  10564282	<b>Applicant(s)/Patent Under Reexamination</b>  SEITZ ET AL.
	<b>Examiner</b>  SHEELA C CHAWAN	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	144, 145,151 , 173, 181, 283.	12/8/08	SCC
356	237.4, 237.5, 237.2, 237.3,	"	"

SEARCH NOTES		
Search Notes	Date	Examiner
SEARCH EAST AND OTHER DATA BASE.	12/8/08	SCC
INVENTOR NAME SEARCH.	"	"

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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